Search Notes			
	ı		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/925,548	DEDHAR ET AL.	
Examiner	Art Unit	_
Shin-Lin Chen	1632	

SEARCHED				
Class	Subclass	Date	Examiner	
Updated		3/7/2006	4n	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>	<u>.</u>		

STRATEGY)
DATE	EXMR
3/7/2006	m